Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L3	4080	irrespectiv$4 same (orientation position location) same (sensor optical ccd camera video)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:04
L4	4080	irrespectiv$4 same (orientation position location) same (sensor optical ccd camera video)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:04
L5	46	L4 same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:41
L6	3000	(illuminat$4 ligth$4) same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
L7	311	L6 same angle	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
L8	102	(382/111).CCLS.	US-PGPUB; USPAT; USOCR; IBM_TDB	OR	OFF	2005/02/25 15:12
L9	90	angle near5 distor$4 near5 oblique	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
L10	13499	real adj2 imag$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
L11	7	L6 same L10	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:42
L12	1	spectrum same fourier same angle same local same distortion	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:15
L13	388	angle same oblique same distortion	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:43
L14	1	13 same arched	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:43
L15	3	13 same fabric	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:43
L16	9	13 and fabric	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:43
L19	44	angle same oblique same arched	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:47

L20	80864	19 and fabric textile	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:47
L21	4	19 and (fabric textile)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:48
L22	4	arche near4 distortion	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:48
L23	18242	angle near2 oblique	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:48
L24	154	23 same fabric	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:48
L25	3	24 same distor$5	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:54
L26	1	("4786177").PN.	US-PGPUB; USPAT; IBM_TDB	OR	OFF	2005/02/25 14:54
L27	0	23 and 8	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 15:12
S1	2774	(illuminat$4 ligth$4) same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 17:48
S2	278	S1 same angle	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
S3	6	S2 same distort$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:39
S4	93	(382/111).CCLS.	US-PGPUB; USPAT; USOCR; IBM_TDB	OR	OFF	2005/02/25 14:05
S5	35	S4 and angle	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:47
S6	80	angle near5 distor$4 near5 oblique	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
S7	31060	"80" same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:48
S8	1	S6 same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:49

S9	12	S6 and (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:46
S10	3174	angle near4 distor$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:56
S11	3	S10 same S1	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:57
S12	1	S11 same imag$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 16:58
S13	3	S11 and imag$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 17:25
S14	10444	supervi$4 near2 control$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 17:00
S15	1	S14 same S1	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 17:00
S16	12284	real adj2 imag$4	US-PGPUB; USPAT; IBM_TDB	OR	ON	2004/07/21 17:25
S17	7	S1 same S16	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:05
S18	3777	irrespectiv$4 same (orientation position location) same (sensor optical ccd camera video)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:04
S19	45	S18 same (fabric$2 web textil$3)	US-PGPUB; USPAT; IBM_TDB	OR	ON	2005/02/25 14:04

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---

1 **Lithographically fabricated planar holographic Bragg reflectors**
Greiner, C.; Iazikov, D.; Mossberg, T.W.;
Lightwave Technology, Journal of , Volume: 22 , Issue: 1 , Jan. 2004
Pages:136 - 145

[Abstract]   [PDF Full-Text (432 KB)]   **IEEE JNL**

---

2 **Fabric defect detection by Fourier analysis**
Chi-Ho Chan; Pang, G.K.H.;
Industry Applications, IEEE Transactions on , Volume: 36 , Issue: 5 , Sept.-Oc 2000
Pages:1267 - 1276

[Abstract]   [PDF Full-Text (1548 KB)]   **IEEE JNL**

---

3 **Visual servoing and CAD-driven microassembly**
Feddema, J.T.; Simon, R.W.;
Robotics & Automation Magazine, IEEE , Volume: 5 , Issue: 4 , Dec. 1998
Pages:18 - 24

[Abstract]   [PDF Full-Text (1600 KB)]   **IEEE JNL**

---

4 **Experimental confirmation of phase relationships of multimode interference splitters using a shearing-type near-field Sagnac interferometer**
Kareenahalli, S.; Dagenais, M.; Stone, D.; Tayag, T.J.;

Photonics Technology Letters, IEEE , Volume: 9 , Issue: 7 , July 1997
Pages:937 - 939

[Abstract]   [PDF Full-Text (72 KB)]   **IEEE JNL**

---

5 **High-speed ultrasound volumetric imaging system. I. Transducer de and beam steering**
Smith, S.W.; Pavy, H.G., Jr.; von Ramm, O.T.;
Ultrasonics, Ferroelectrics and Frequency Control, IEEE Transactions on , Volu 38 , Issue: 2 , March 1991
Pages:100 - 108

[Abstract]   [PDF Full-Text (764 KB)]   **IEEE JNL**

---

6 **Stent deployment using an integrated semi-compliant balloon ultrasound catheter**
Choi, C.D.; Savage, J.; Stephens, D.N.; O'Donnell, M.;
Ultrasonics Symposium, 2002. Proceedings. 2002 IEEE , Volume: 2 , 8-11 Oct 2002
Pages:1795 - 1798 vol.2

[Abstract]   [PDF Full-Text (339 KB)]   **IEEE CNF**

---

7 **Thermal modeling, measurements and design considerations of GaA microwave devices**
Dawson, D.E.;
Gallium Arsenide Integrated Circuit (GaAs IC) Symposium, 1994. Technical Di 1994., 16th Annual , 16-19 Oct. 1994
Pages:285 - 290

[Abstract]   [PDF Full-Text (564 KB)]   **IEEE CNF**

---

8 **Infrared detector assemblies for the tropospheric emission spectrometer**
Bruce, C.F.; Bajaj, J.; Lee, D.; Pepper, T.A.; Chu, G.; McLevige, W.V.; Edwall, D.D.; McGregor, L.A.; Weissbard, W.; Hildebrandt, G.; Blackwell, J.D.; Bhargz S.; Gil, V.; Cooper, D.E.; Spariosu, K.; Arias, J.M.; Tennant, W.E.; Vural, K.; : L.;
Aerospace Conference Proceedings, 2000 IEEE , Volume: 3 , 18-25 March 200
Pages:193 - 205 vol.3

[Abstract]   [PDF Full-Text (1220 KB)]   **IEEE CNF**

---

9 **Theoretical MEF calculation for periodic patterns**
Terasawa, T.; Hasegawa, N.;
Microprocesses and Nanotechnology Conference, 2000 International , 11-13 J 2000
Pages:16 - 17

[Abstract]   [PDF Full-Text (144 KB)]   **IEEE CNF**

---

10 **Speckle-free non-periodic Fresnel phase plates for beam shaping a optical interconnects**
Neto, L.G.; Yunlong Sheng; Galmiche, F.;
Microwave and Optoelectronics Conference, 1997. 'Linking to the Next Centur
Proceedings., 1997 SBMO/IEEE MTT-S International , Volume: 1 , 11-14 Aug.

Pages:82 - 86 vol.1

[Abstract]   [PDF Full-Text (344 KB)]   **IEEE CNF**

---

11 **A new FFT architecture and chip design for motion compensation b on phase correlation**
Hui, C.C.W.; Ding, T.J.; McCanny, J.V.; Woods, R.F.;
Application Specific Systems, Architectures and Processors, 1996. ASAP 96.
Proceedings of International Conference on , 19-21 Aug. 1996
Pages:83 - 92

[Abstract]   [PDF Full-Text (588 KB)]   **IEEE CNF**

---

12 **Fabrication and characterization of THz plasmonic filter**
Dongmin Wu; Fang, N.; Cheng Sun; Xiang Zhang; Padilla, W.; Basov, D.; Sm. D.;
Nanotechnology, 2002. IEEE-NANO 2002. Proceedings of the 2002 2nd IEEE
Conference on , 26-28 Aug. 2002
Pages:229 - 231

[Abstract]   [PDF Full-Text (320 KB)]   **IEEE CNF**

---

13 **Radiation tolerant digital signal processor transformation**
Sampson, S.; Ramaswamy, S.; Alcorn, C.; Haddad, N.; Lawson, D.; Page, T.; Scandalis, G.; Scott, T.; Robinson, P.; Bain, D.;
Aerospace Conference, 1999. Proceedings. 1999 IEEE , Volume: 2 , 6-13 Mar(
1999
Pages:263 - 272 vol.2

[Abstract]   [PDF Full-Text (784 KB)]   **IEEE CNF**

---

14 **Fabric defect detection by Fourier analysis**
Chi-Ho Chan; Pang, G.;
Industry Applications Conference, 1999. Thirty-Fourth IAS Annual Meeting.
Conference Record of the 1999 IEEE , Volume: 3 , 3-7 Oct. 1999
Pages:1743 - 1750 vol.3.

[Abstract]   [PDF Full-Text (712 KB)]   **IEEE CNF**

---

15 **CAD-driven microassembly and visual servoing**
Feddema, J.T.; Simon, R.W.;
Robotics and Automation, 1998. Proceedings. 1998 IEEE International Confere
on , Volume: 2 , 16-20 May 1998
Pages:1212 - 1219 vol.2

[Abstract]   [PDF Full-Text (820 KB)]   **IEEE CNF**

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---

16 **Gray-level image generation by multiphase diffraction grating**
Lee, D.J.; Kim, N.; Song, S.H.; Suh, H.H.;
Lasers and Electro-Optics Society Annual Meeting, 1995. 8th Annual Meeting Conference Proceedings, Volume 1., IEEE , Volume: 1 , 30-31 Oct. 1995
Pages:73 - 74 vol.1

[Abstract]   [PDF Full-Text (240 KB)]   IEEE CNF

---

17 **Time-domain modeling of composite arrays for underwater imagin(**
Wojcik, G.L.; Vaughan, D.K.; Murray, V.; Mould, J., Jr.;
Ultrasonics Symposium, 1994. Proceedings., 1994 IEEE , Volume: 2 , 1-4 Nov 1994
Pages:1027 - 1032 vol.2

[Abstract]   [PDF Full-Text (744 KB)]   IEEE CNF

---

18 **New shunt wiring technologies for high performance HDTV CCD im. sensors**
Orihara, K.; Minami, K.; Nakano, T.; Hatano, K.; Furumiya, M.; Mutoh, N.; Ol M.; Hokari, Y.;
Electron Devices Meeting, 1992. Technical Digest., International , 13-16 Dec.
Pages:105 - 108

[Abstract]   [PDF Full-Text (216 KB)]   IEEE CNF

---

19 **A 40 MHz programmable and reconfigurable filter processor**

Cai, M.M.; Luthi, D.A.; Ruetz, P.A.; Ang, P.H.;
Custom Integrated Circuits Conference, 1990., Proceedings of the IEEE 1990,
16 May 1990
Pages:13.2/1 - 13.2/4

[Abstract]   [PDF Full-Text (360 KB)]   **IEEE CNF**

---

20 **Range imaging sensors development at NRC Laboratories**
Rioux, M.; Blais, F.; Beraldin, J.; Boulanger, P.;
Interpretation of 3D Scenes, 1989. Proceedings., Workshop on , 27-29 Nov. 1
Pages:154 - 160

[Abstract]   [PDF Full-Text (824 KB)]   **IEEE CNF**

---

21 **Computer generated microlens arrays and their application to optic**
free space switching networks
Bird, K.D.; Daly, D.; Hall, T.J.;
Holographic Systems, Components and Applications, 1991., Third Internationa
Conference on , 16-18 Sep 1991
Pages:57 - 61

[Abstract]   [PDF Full-Text (332 KB)]   **IEE CNF**